

REFERENCE DESIGNATION U.S. P

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U.S.	PAI	ENI	DOC	UM	ENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS/ SUBCLASS	FILING DATE
۲, ۲۰	A1	4,217,587	8/12/1980	Jacomini		
C.C.	A2	4,850,037	7/18/1989	Bochmann		
C.C.	A3	5,345,602	9/6/1994	Wiedemann et al.		1
C.C.	A4	5,404,588	4/4/1995	Henze		
C, C,	A5	5,778,324	7/7/1998	Smith		
C.C.	A6	6,064,865	5/16/2000	Kuo et al.		
C.C.	A7	6,141,536	10/31/2000	Cvetkovic et al.		

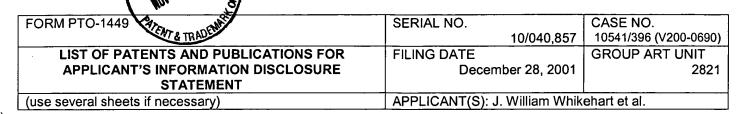
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EXAMINER	DOCUMENT			CLASS/	TRANS	LATION
INITIAL	NUMBER	DATE	COUNTRY	SUBCLASS	YES	NO

EXAMINER		
INITIAL	OTHER ART (Including A discretified B 4 B 42 A B	
INITIAL	OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)	

EXAMINER	DATE CONSIDERED
LCHOW	5/7/04

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U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER Number-Kind Code (if known)	DATE	NAME	CLASS/ SUBCLASS	FILING DATE
C.C.	B1	US 2002/0004375 A1	1/10/2002	Spencer et al.		
CC	B2	US 2002/0080894 A1	6/27/2002	Dabak et al.		

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EXAMINER INITIAL		DOCUMENT NUMBER Number-Kind Code (if known)	DATE	COUNTRY	CLASS/ SUBCLASS	TRANSLATION YES OR NO
e.C.	B3	GB 2 314 234 A	12/17/1997	GB		Yes
C.C.	B4	EP 1 227 542 A1	7/31/2002	EPO		Yes

EXAMINER INITIAL	OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)

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C.CHOW	5/7/2/1
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